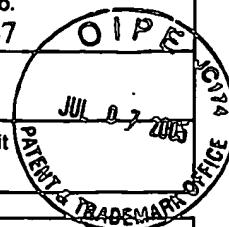


Substitute Form PTO-1449 (Modified) Information Disclosure Statement by Applicant (Use several sheets if necessary) (37 CFR §1.98(b))	U.S. Department of Commerce Patent and Trademark Office	Attorney's Docket No. 12732-185001	Application No. 10/730,047
	Applicant Shunpei Yamazaki et al.		
	Filing Date December 9, 2003	Group Art Unit 2822	



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EXAMINER: Initials citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.	

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Other Documents (include Author, Title, Date, and Place of Publication)		
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	AHH	"Mass Production of Organic EL Devices"; <i>Shimotsuke Newspaper</i> ; July 3, 2003 (full translation)
	AII	"Two-way display developed"; Newspaper " <i>The Japan Times</i> "; July 3, 2003
	AJJ	<i>Exhibition of Active Matrix Type Organic EL Display at "13th Flat Panel Display Manufacturing Technology Expo & Conference"</i> by ELDis Group; July 2, 2003 (full translation)
	AKK	Documents distributed in the " <i>13th Flat Panel Display Manufacturing Technology Expo & Conference</i> " by ELDis Group; July 2, 2003 (full translation)

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	AO							
	AP							

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	AS	
	AT	

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	AI						
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	AN							
	AO							
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